Notice of References Cited Application/Control No. 10/630,124 Examiner Pablo N. Tran Applicant(s)/Patent Under Reexamination HAUB ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0038656	02-2004	McCall et al.	455/138
*	В	US-2005/0075077	04-2005	Mach et al.	455/067.13
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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